1. General description

The 74ABT16244A high-performance Bipolar CMOS (BiCMOS) device combines low static and dynamic power dissipation with high speed and high output drive.

The 74ABT16244A is a 16-bit buffer that is ideal for driving bus lines. The device features four output enable inputs ($1\overline{OE}$, $2\overline{OE}$, $3\overline{OE}$, $4\overline{OE}$), each controlling four of the 3-state outputs.

2. Features and benefits

- 16-bit bus interface
- Multiple V_{CC} and GND pins minimize switching noise
- Power-up 3-state
- 3-state buffers
- Output capability: +64 mA and -32 mA
- Live insertion and extraction permitted
- Latch-up performance: JESD 78 Class II
- ESD protection:
 - HBM JESD-A114E exceeds 2000 V
 - CDM JESD 22-C101-C exceeds 1000 V

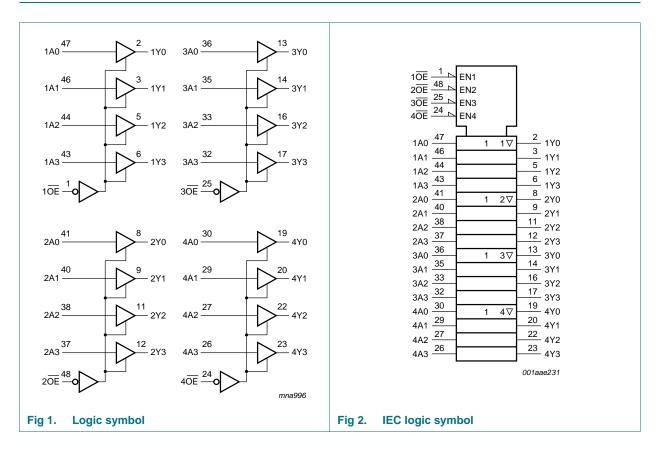
3. Ordering information

Type number	Package						
	Temperature range	Name	Description	Version			
74ABT16244ADGG	–40 °C to +85 °C	TSSOP48	plastic thin shrink small outline package; 48 leads; body width 6.1 mm	SOT362-1			
74ABT16244ADL	–40 °C to +85 °C	SSOP48	plastic shrink small outline package; 48 leads; body width 7.5 mm	SOT370-1			





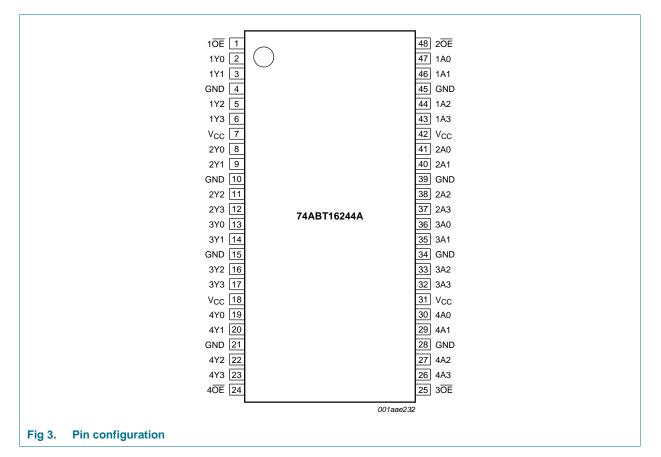
4. Functional diagram





5. Pinning information

5.1 Pinning



5.2 Pin description

Table 2.	Pin description	
Symbol	Pin	Description
1OE	1	1 output enable (LOW active)
1Y[0:3]	2, 3, 5, 6	1 data output 0 to output 3
GND	4	ground (0 V)
V _{CC}	7	supply voltage
2Y[0:3]	8, 9, 11, 12	2 data output 0 to output 3
GND	10	ground (0 V)
3Y[0:3]	13, 14, 16, 17	3 data output 0 to output 3
GND	15	ground (0 V)
V _{CC}	18	supply voltage
4Y[0:3]	19, 20, 22, 23	4 data output 0 to output 3
GND	21	ground (0 V)

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Table 2.	Pin descriptioncontinue	d
Symbol	Pin	Description
4OE	24	4 output enable (LOW active)
3 <mark>OE</mark>	25	3 output enable (LOW active)
GND	28	ground (0 V)
4A[0:3]	30, 29, 27, 26	4 data input 0 to input 3
V _{CC}	31	supply voltage
GND	34	ground (0 V)
3A[0:3]	36, 35, 33, 32	3 data input 0 to input 3
GND	39	ground (0 V)
2A[0:3]	41, 40, 38, 37	2 data input 0 to input 3
V _{CC}	42	supply voltage
GND	45	ground (0 V)
1A[0:3]	47, 46, 44, 43	1 data input 0 to input 3
2 <mark>0E</mark>	48	2 output enable (LOW active)

6. Functional description

Table	3.	Function	table ^[1]
	.		

Control	Input	Output
n <mark>OE</mark>	nAn	nYn
L	L	L
	Н	Н
Н	Х	Z

[1] H = HIGH voltage level;

L = LOW voltage level;

X = don t care;

Z = high-impedance OFF-state.

7. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V _{CC}	supply voltage		-0.5	+7.0	V
VI	input voltage		<u>[1]</u> –1.2	+7.0	V
Vo	output voltage	output in OFF-state or HIGH-state	<u>[1]</u> –0.5	+5.5	V
I _{IK}	input clamping current	V _I < 0 V	-18	-	mA
I _{OK}	output clamping current	V _O < 0 V	-50	-	mA
lo	output current	output in LOW-state	-	128	mA
		output in HIGH-state	-	-64	mA
Tj	junction temperature		[2] _	150	°C
T _{stg}	storage temperature		-65	+150	°C

[1] The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

[2] The performance capability of a high-performance integrated circuit in conjunction with its thermal environment can create junction temperatures which are detrimental to reliability.

8. Recommended operating conditions

Table 5. Operating conditions

Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V _{CC}	supply voltage		4.5	-	5.5	V
VI	input voltage	0	-	V _{CC}	V	
V _{IH}	HIGH-level input voltage	2.0	-	-	V	
V _{IL}	LOW-level Input voltage	-	-	0.8	V	
I _{OH}	HIGH-level output current		-32	-	-	mA
I _{OL}	LOW-level output current		-	-	64	mA
Δt/ΔV	input transition rise and fall rate		-	-	10	ns/V
T _{amb}	ambient temperature	in free air	-40	-	+85	°C

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9. Static characteristics

Symbol	Parameter	Conditions		25 °C			–40 °C t	Unit	
					Тур	Max	Min	Max	
V _{IK}	input clamping voltage	V_{CC} = 4.5 V; I _{IK} = -18 mA		-	-0.9	-1.2	-	-1.2	V
V _{OH}	HIGH-level output	$V_{I} = V_{IL} \text{ or } V_{IH}$							
	voltage	V_{CC} = 4.5 V; I_{OH} = -3 mA		2.5	2.9	-	2.5	-	V
		V_{CC} = 5.0 V; I_{OH} = -3 mA		3.0	3.4	-	3.0	-	V
		V_{CC} = 4.5 V; I_{OH} = -32 mA		2.0	2.4	-	2.0	-	V
V _{OL}	LOW-level output voltage	/ _{CC} = 4.5 V; I _{OL} = 64 mA; / _I = V _{IL} or V _{IH}		-	0.42	0.55	-	0.55	V
l _l	input leakage current	V_{CC} = 5.5 V; V_I = V_{CC} or GND		-	±0.01	±1.0	-	±1.0	μA
I _{OFF}	power-off leakage current	V_{CC} = 0 V; V_{I} or $V_{O} \leq 4.5$ V		-	±5.0	±100	-	±100	μA
I _{O(pu/pd)}	power-up/power-down output current	$V_{CC} = 2.0 V; V_{O} = 0.5 V;$ V _I = GND or V _{CC} ; nOE = HIGH		-	±5.0	±50	-	±50	μA
l _{oz}	OFF-state output current	V_{CC} = 5.5 V; V_I = V_{IL} or V_{IH}							
		output HIGH-state at V_{O} = 5.5 V		-	0.1	10	-	10	μA
		output LOW-state at $V_0 = 0 V$		-	-0.1	-10	-	-10	μA
I _{LO}	output leakage current	HIGH-state; $V_O = 5.5 V$; $V_{CC} = 5.5 V$; $V_I = GND \text{ or } V_{CC}$		-	5.0	50	-	50	μA
lo	output current	V_{CC} = 5.5 V; V_{O} = 2.5 V	[2]	-50	-100	-180	-50	-180	mA
I _{CC}	supply current	V_{CC} = 5.5 V; V_I = GND or V_{CC}							
		outputs HIGH-state		-	0.45	1.0	-	1.0	mA
		outputs LOW-state		-	10	19	-	19	mA
		outputs 3-state		-	0.45	1.0	-	1.0	mA
ΔI _{CC}	additional supply current	per input pin; V_{CC} = 5.5 V; one input at 3.4 V and other inputs at V_{CC} or GND	<u>[3][4]</u>	-	100	250	-	250	μA
CI	input capacitance	$V_I = 0 V \text{ or } V_{CC}$		-	4	-	-	-	pF
C _{I/O}	input/output capacitance	outputs disabled; V_{O} = 0 V or V_{CC}		-	7	-	-	-	pF

[1] This parameter is valid for any V_{CC} between 0 V and 2.1 V, with a transition time of up to 10 ms. From V_{CC} = 2.1 V to V_{CC} = 5 V \pm 10 %, a transition time of up to 100 μ s is permitted.

[2] Not more than one output should be tested at a time, and the duration of the test should not exceed one second.

[3] This is the increase in supply current for each input at 3.4 V.

[4] This data sheet limit may vary among suppliers.



10. Dynamic characteristics

Table 7. Dynamic characteristics

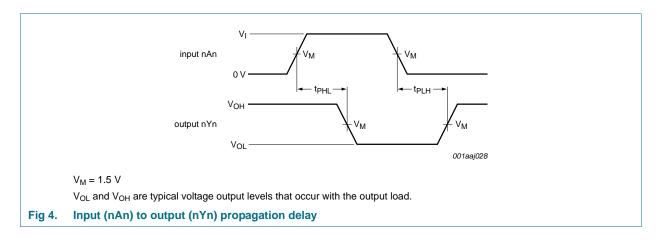
GND = 0 V. For test circuit, see Figure 6.

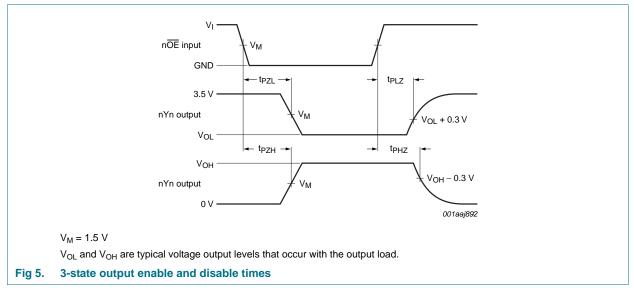
Symbol	Parameter	Conditions	25 °C; V _{CC} = 5.0 V			-40 °C to V _{CC} = 5.0	Unit	
			Min	Тур	Мах	Min	Max	
t _{PLH}	LOW to HIGH propagation delay	nAn to nYn, see <u>Figure 4</u>	1.1	1.7	2.6	1.1	2.8	ns
t _{PHL}	HIGH to LOW propagation delay	nAn to nYn, see <u>Figure 4</u>	1.3	2.1	2.9	1.3	3.4	ns
t _{PZH}	OFF-state to HIGH propagation delay	nOE to nYn; see <u>Figure 5</u>	1.6	2.7	3.7	1.6	4.5	ns
t _{PZL}	OFF-state to LOW propagation delay	nOE to nYn; see <u>Figure 5</u>	2.3	3.5	4.0	2.3	4.8	ns
t _{PHZ}	HIGH to OFF-state propagation delay	nOE to nYn; see <u>Figure 5</u>	1.5	3.0	4.0	1.5	4.6	ns
t _{PLZ}	LOW to OFF-state propagation delay	nOE to nYn; see <u>Figure 5</u>	1.6	2.4	3.2	1.6	4.1	ns

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11. Waveforms





16-bit buffer/line driver; 3-state

12. Test information

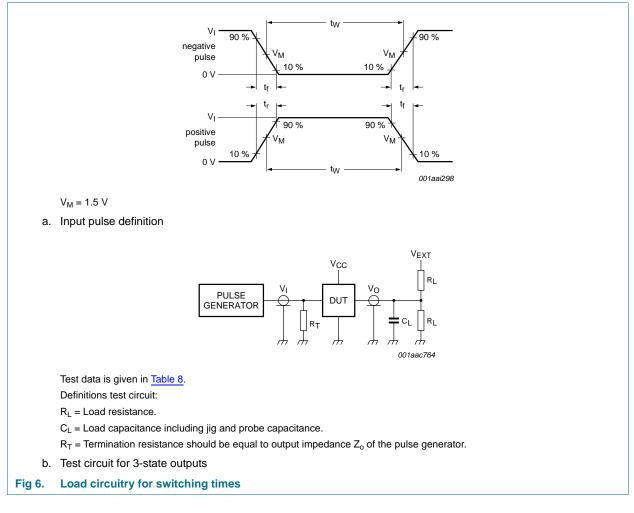


Table 8. Test data

Input			Load		V _{EXT}			
VI	f _i	tw	t _r , t _f	CL	R _L	t _{PHZ} , t _{PZH} t _{PLZ} , t _{PZL}		t _{PLH} , t _{PHL}
3.0 V	1 MHz	500 ns	2.5 ns	50 pF	500 Ω	open	7.0 V	open



13. Package outline

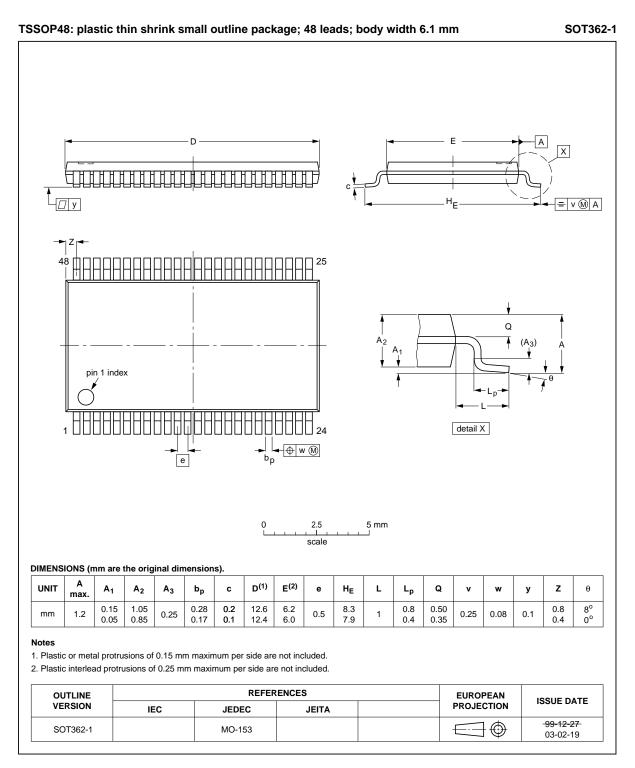


Fig 7. Package outline SOT362-1 (TSSOP48)

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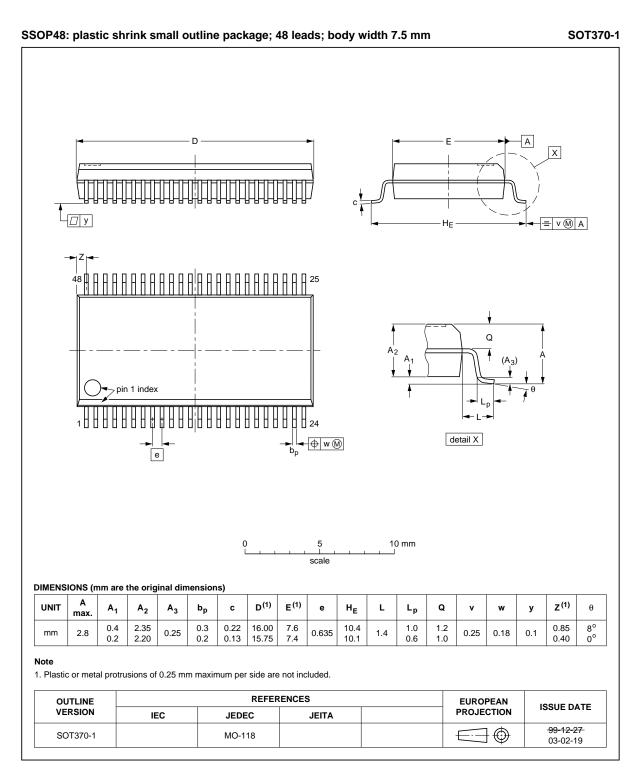


Fig 8. Package outline SOT370-1 (SSOP48)

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14. Revision history

Table 9. Revision	history			
Document ID	Release date	Data sheet status	Change notice	Supersedes
74ABT16244A v.8	20111103	Product data sheet	-	74ABT16244A v.7
Modifications:	 Legal pages 	updated		
74ABT16244A v.7	20100525	Product data sheet	-	74ABT16244A v.6
74ABT16244A v.6	20090323	Product data sheet	-	74ABT16244A v.5
74ABT16244A v.5	20060210	Product data sheet	-	74ABT_H16244A v.4
74ABT_H16244A v.4	19981007	Product specification	-	74ABT_H16244A v.3
74ABT_H16244A v.3	19980225	Product specification	-	74ABT_H16244A v.2



15. Legal information

15.1 Data sheet status

Document status[1][2]	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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Date of release: 3 November 2011 Document identifier: 74ABT16244A